



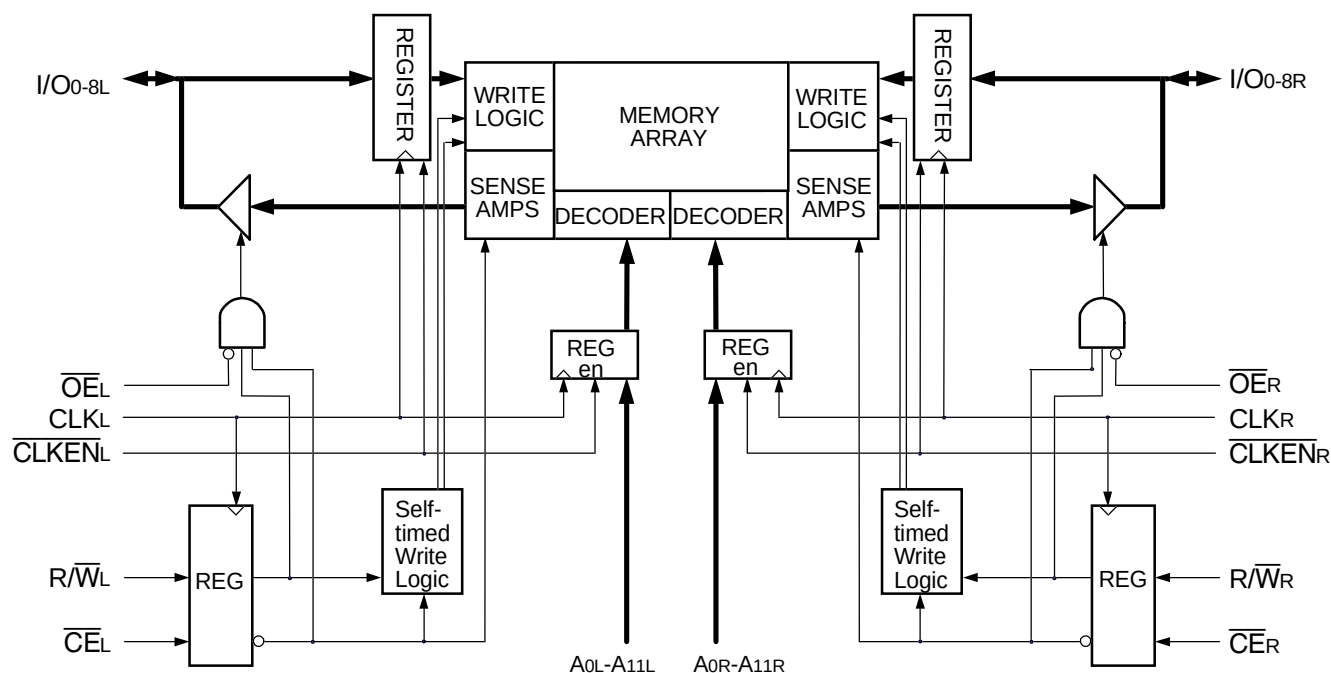
## HIGH SPEED 36K (4K X 9) SYNCHRONOUS DUAL-PORT RAM

IDT70914S

### Features

- ♦ High-speed clock-to-data output times
  - Military: 20/25ns (max.)
  - Commercial: 12/15/20ns (max.)
- ♦ Low-power operation
  - IDT70914S
  - Active: 850 mW (typ.)
  - Standby: 50 mW (typ.)
- ♦ Architecture based on Dual-Port RAM cells
  - Allows full simultaneous access from both ports
- ♦ Synchronous operation
  - 4ns setup to clock, 1ns hold on all control, data, and address inputs
  - Data input, address, and control registers
- Fast 12ns clock to data out
- Self-timed write allows fast cycle times
- 16ns cycle times, 60MHz operation
- ♦ TTL-compatible, single 5V ( $\pm 10\%$ ) power supply
- ♦ Clock Enable feature
- ♦ Guaranteed data output hold times
- ♦ Available in 68-pin PLCC, and 80-pin TQFP
- ♦ Military product compliant to MIL-PRF-38535 QML
- ♦ Industrial temperature range (-40°C to +85°C) is available for selected speeds.
- ♦ Recommended for replacement of IDT7099 (4K x 9) if separate 9th bit data control signals are not required.

### Functional Block Diagram



3490 drw 01

JANUARY 2001

## Description

The IDT70914 is a high-speed 4K x 9 bits synchronous Dual-Port RAM. The memory array is based on Dual-Port memory cells to allow simultaneous access from both ports. Registers on control, data, and address inputs provide low set-up and hold times. The timing latitude provided by this approach allow systems to be designed with very short cycle times. With an input data register, this device has been optimized for applications having unidirectional data flow or bi-directional data flow in bursts.

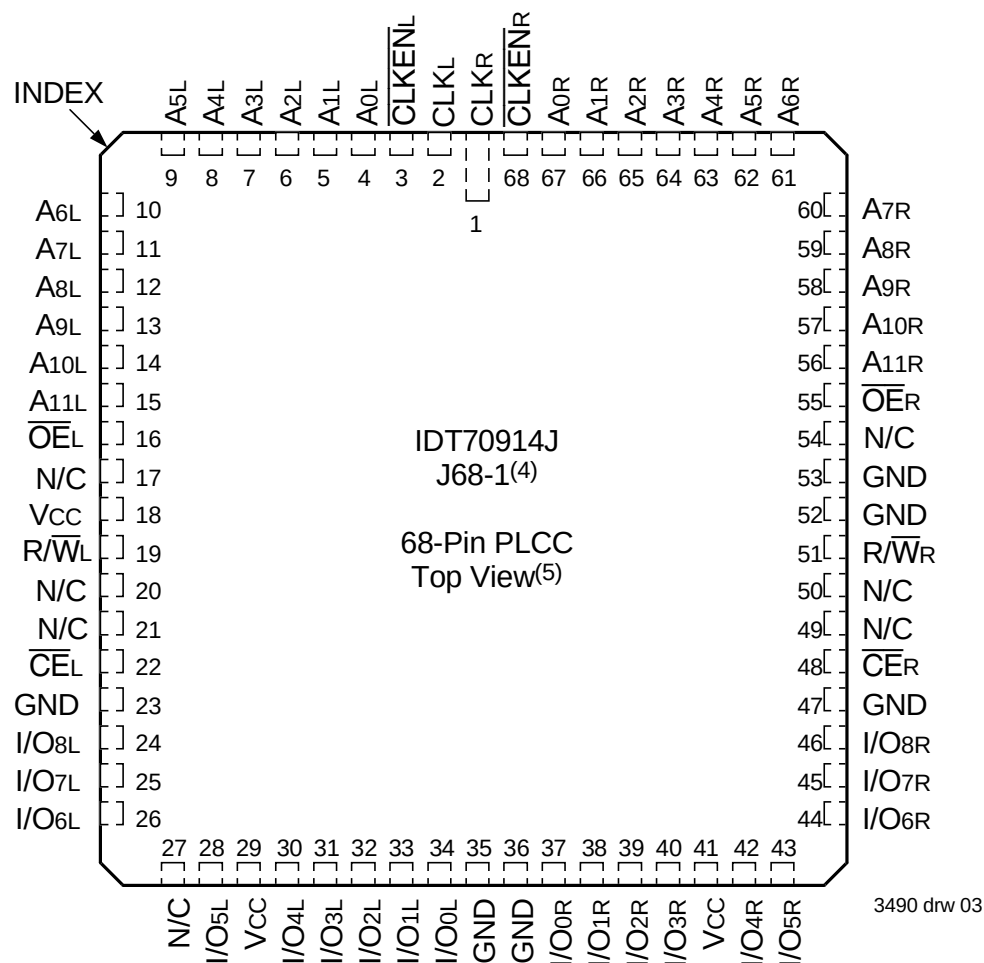
The IDT70914 utilizes a 9-bit wide data path to allow for parity at the user's option. This feature is especially useful in data communication applications where it is necessary to use a parity bit for transmission/

reception error checking.

Fabricated using IDT's CMOS high-performance technology, these Dual-Ports typically operate on only 850mW of power at maximum high-speed clock-to-data output times as fast as 12ns. An automatic power down feature, controlled by  $\overline{CE}$ , permits the on-chip circuitry of each port to enter a very low standby power mode.

The IDT70914 is packaged in a 68-pin PLCC, and an 80-pin TQFP. Military grade product is manufactured in compliance with the latest revision of MIL-PRF-38535 QML, making it ideally suited for military temperature applications demanding the highest level of performance and reliability.

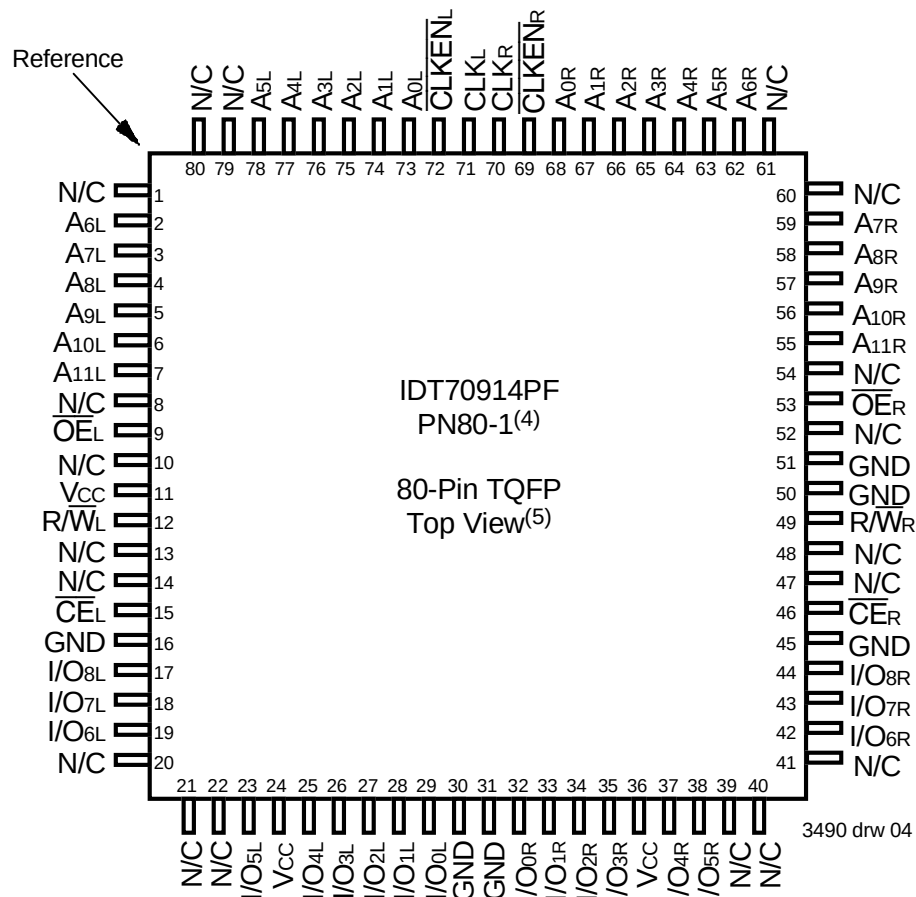
## Pin Configurations<sup>(1,2,3)</sup>



### NOTES:

1. All Vcc pins must be connected to power supply.
2. All ground pins must be connected to ground supply.
3. J68-1 package body is approximately .95 in x .95 in x .17 in.
4. This package code is used to reference the package diagram.
5. This text does not indicate orientation of the actual part-marking.

## Pin Configuration<sup>(1,2,3)</sup> (con't.)



### NOTES:

1. All V<sub>cc</sub> pins must be connected to power supply.
2. All ground pins must be connected to ground supply.
3. PN80-1 package body is approximately 14mm x 14mm x 1.4mm.
4. This package code is used to reference the package diagram.
5. This text does not indicate orientation of the actual part-marking.

**Absolute Maximum Ratings<sup>(1)</sup>**

| Symbol           | Rating                               | Commercial & Industrial | Military         | Unit |
|------------------|--------------------------------------|-------------------------|------------------|------|
| $V_{TERM}^{(2)}$ | Terminal Voltage with Respect to GND | -0.5 to +7.0            | -0.5 to +7.0     | V    |
| $V_{TERM}^{(2)}$ | Terminal Voltage                     | -0.5 to $V_{CC}$        | -0.5 to $V_{CC}$ | V    |
| $T_{BIAS}$       | Temperature Under Bias               | -55 to +125             | -65 to +135      | °C   |
| $T_{STG}$        | Storage Temperature                  | -65 to +150             | -65 to +150      | °C   |
| $I_{OUT}$        | DC Output Current                    | 50                      | 50               | mA   |

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**NOTES:**

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
- $V_{TERM}$  must not exceed  $V_{CC} + 10\%$  for more than 25% of the cycle time or 10ns maximum, and is limited to  $\leq 20mA$  for the period of  $V_{TERM} \geq V_{CC} + 10\%$ .

**Capacitance****( $T_A = +25^\circ C$ ,  $f = 1.0MHz$ ) TQFP Only**

| Symbol    | Parameter          | Conditions      | Max. | Unit |
|-----------|--------------------|-----------------|------|------|
| $C_{IN}$  | Input Capacitance  | $V_{IN} = 3dV$  | 8    | pF   |
| $C_{OUT}$ | Output Capacitance | $V_{OUT} = 3dV$ | 9    | pF   |

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**NOTES:**

- These parameters are determined by device characterization, but are not production tested.
- 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.

**Maximum Operating Temperature and Supply Voltage<sup>(1,2)</sup>**

| Grade      | Ambient Temperature | GND | $V_{CC}$        |
|------------|---------------------|-----|-----------------|
| Military   | -55°C to +125°C     | 0V  | $5.0V \pm 10\%$ |
| Commercial | 0°C to +70°C        | 0V  | $5.0V \pm 10\%$ |
| Industrial | -40°C to +85°C      | 0V  | $5.0V \pm 10\%$ |

3490 tbl 02

**NOTES:**

- This is the parameter  $T_A$ . This is the "instant on" case temperature.
- Industrial temperature: for specific speeds, packages and powers contact your

**Recommended DC Operating Conditions**

| Symbol   | Parameter          | Min.                | Typ. | Max.        | Unit |
|----------|--------------------|---------------------|------|-------------|------|
| $V_{CC}$ | Supply Voltage     | 4.5                 | 5.0  | 5.5         | V    |
| GND      | Ground             | 0                   | 0    | 0           | V    |
| $V_{IH}$ | Input High Voltage | 2.2                 | —    | $6.0^{(2)}$ | V    |
| $V_{IL}$ | Input Low Voltage  | -0.5 <sup>(1)</sup> | —    | 0.8         | V    |

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**NOTES:**

- $V_{IL} \geq -1.5V$  for pulse width less than 10ns.
- $V_{TERM}$  must not exceed  $V_{CC} + 10\%$ .

**DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range ( $V_{CC} = 5.0V \pm 10\%$ )**

| Symbol     | Parameter                            | Test Conditions                                       | 70914S |      | Unit    |
|------------|--------------------------------------|-------------------------------------------------------|--------|------|---------|
|            |                                      |                                                       | Min.   | Max. |         |
| $ I_{L} $  | Input Leakage Current <sup>(1)</sup> | $V_{CC} = 5.5V$ , $V_{IN} = 0V$ to $V_{CC}$           | —      | 10   | $\mu A$ |
| $ I_{LO} $ | Output Leakage Current               | $\overline{CE} = V_{IH}$ , $V_{OUT} = 0V$ to $V_{CC}$ | —      | 10   | $\mu A$ |
| $V_{OL}$   | Output Low Voltage                   | $I_{OL} = +4mA$                                       | —      | 0.4  | V       |
| $V_{OH}$   | Output High Voltage                  | $I_{OH} = -4mA$                                       | 2.4    | —    | V       |

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**NOTE:**

- At  $V_{CC} \leq 2.0V$ , input leakages are undefined

## DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range<sup>(4,5)</sup> ( $V_{CC} = 5V \pm 10\%$ )

| Symbol           | Parameter                                                 | Test Condition                                                                                                                                                                                  | Version   | 70914S12<br>Com'l Only |      | 70914S15<br>Com'l Only |      | Unit |
|------------------|-----------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|------------------------|------|------------------------|------|------|
|                  |                                                           |                                                                                                                                                                                                 |           | Typ. <sup>(2)</sup>    | Max. | Typ. <sup>(2)</sup>    | Max. |      |
| I <sub>CC</sub>  | Dynamic Operating Current<br>(Both Ports Active)          | $\overline{CE_L}$ and $\overline{CE_R} = V_{IL}$ ,<br>Outputs Disabled<br>$f = f_{MAX}^{(1)}$                                                                                                   | COM'L     | 190                    | 310  | 180                    | 300  | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | —                      | —    | —                      | —    |      |
| I <sub>SB1</sub> | Standby Current<br>(Both Ports - TTL Level Inputs)        | $\overline{CE_L}$ and $\overline{CE_R} = V_{IH}$<br>$f = f_{MAX}^{(1)}$                                                                                                                         | COM'L     | 95                     | 150  | 90                     | 140  | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | —                      | —    | —                      | —    |      |
| I <sub>SB2</sub> | Standby Current<br>(One Port - TTL Level Inputs)          | $\overline{CE_A}^* = V_{IL}$ and<br>$\overline{CE_B}^* = V_{IH}^{(3)}$<br>Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$                                                                     | COM'L     | 170                    | 220  | 160                    | 210  | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | —                      | —    | —                      | —    |      |
| I <sub>SB3</sub> | Full Standby Current (Both Ports - All CMOS Level Inputs) | Both Ports $\overline{CE_R}$ and<br>$\overline{CE_L} \geq V_{CC} - 0.2V$<br>$V_{IN} \geq V_{CC} - 0.2V$ or<br>$V_{IN} \leq 0.2V$ , $f = 0^{(2)}$                                                | COM'L     | 10                     | 15   | 10                     | 15   | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | —                      | —    | —                      | —    |      |
| I <sub>SB4</sub> | Full Standby Current (One Port - All CMOS Level Inputs)   | $\overline{CE_A}^* \leq 0.2V$ and<br>$\overline{CE_B}^* \geq V_{CC} - 0.2V^{(3)}$<br>$V_{IN} \geq V_{CC} - 0.2V$ or<br>$V_{IN} \leq 0.2V$ , Active Port Outputs Disabled<br>$f = f_{MAX}^{(1)}$ | COM'L     | 165                    | 210  | 155                    | 200  | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | —                      | —    | —                      | —    |      |

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| Symbol           | Parameter                                                 | Test Condition                                                                                                                                                                                  | Version   | 70914S20<br>Com'l & Military |      | 70914S25<br>Military Only |      | Unit |
|------------------|-----------------------------------------------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------|------------------------------|------|---------------------------|------|------|
|                  |                                                           |                                                                                                                                                                                                 |           | Typ. <sup>(2)</sup>          | Max. | Typ. <sup>(2)</sup>       | Max. |      |
| I <sub>CC</sub>  | Dynamic Operating Current<br>(Both Ports Active)          | $\overline{CE_L}$ and $\overline{CE_R} = V_{IL}$ ,<br>Outputs Disabled<br>$f = f_{MAX}^{(1)}$                                                                                                   | COM'L     | 170                          | 290  | —                         | —    | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | 170                          | 310  | 160                       | 290  |      |
| I <sub>SB1</sub> | Standby Current<br>(Both Ports - TTL Level Inputs)        | $\overline{CE_L}$ and $\overline{CE_R} = V_{IH}$<br>$f = f_{MAX}^{(1)}$                                                                                                                         | COM'L     | 85                           | 130  | —                         | —    | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | 85                           | 140  | 80                        | 130  |      |
| I <sub>SB2</sub> | Standby Current<br>(One Port - TTL Level Inputs)          | $\overline{CE_A}^* = V_{IL}$ and<br>$\overline{CE_B}^* = V_{IH}^{(3)}$<br>Active Port Outputs Disabled, $f = f_{MAX}^{(1)}$                                                                     | COM'L     | 150                          | 200  | —                         | —    | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | 150                          | 210  | 140                       | 200  |      |
| I <sub>SB3</sub> | Full Standby Current (Both Ports - All CMOS Level Inputs) | Both Ports $\overline{CE_R}$ and<br>$\overline{CE_L} \geq V_{CC} - 0.2V$<br>$V_{IN} \geq V_{CC} - 0.2V$ or<br>$V_{IN} \leq 0.2V$ , $f = 0^{(2)}$                                                | COM'L     | 10                           | 15   | —                         | —    | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | 10                           | 20   | 10                        | 20   |      |
| I <sub>SB4</sub> | Full Standby Current (One Port - All CMOS Level Inputs)   | $\overline{CE_A}^* \leq 0.2V$ and<br>$\overline{CE_B}^* \geq V_{CC} - 0.2V^{(3)}$<br>$V_{IN} \geq V_{CC} - 0.2V$ or<br>$V_{IN} \leq 0.2V$ , Active Port Outputs Disabled<br>$f = f_{MAX}^{(1)}$ | COM'L     | 145                          | 190  | —                         | —    | mA   |
|                  |                                                           |                                                                                                                                                                                                 | MIL & IND | 145                          | 200  | 135                       | 190  |      |

### NOTES:

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- At  $f_{MAX}$ , address and control lines (except Output Enable) are cycling at the maximum frequency clock cycle of  $1/t_{cyc}$ , using "AC TEST CONDITIONS" at input levels of GND to 3V.
- $f = 0$  means no address, clock, or control lines change. Applies only to input at CMOS level standby.
- Port "A" may be either left or right port. Port "B" is the opposite from port "A".
- $V_{CC} = 5V$ ,  $T_A = 25^\circ C$  for Typ, and are not production tested.  $I_{CC DC} = 150mA$  (Typ).
- Industrial temperature: for specific speeds, packages and powers contact your sales office.

## AC Test Conditions

|                               |                   |
|-------------------------------|-------------------|
| Input Pulse Levels            | GND to 3.0V       |
| Input Rise/Fall Times         | 3ns Max.          |
| Input Timing Reference Levels | 1.5V              |
| Output Reference Levels       | 1.5V              |
| Output Load                   | Figures 1,2 and 3 |

3490 tbl 07

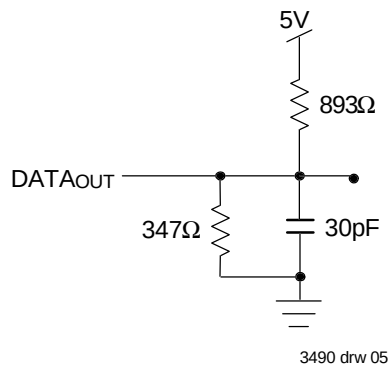


Figure 1. AC Output Test load.

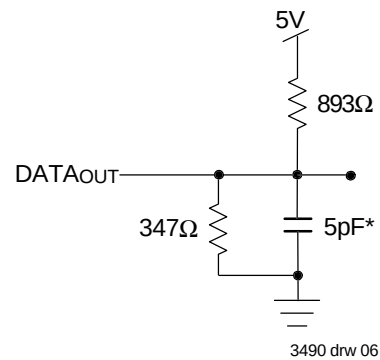


Figure 2. Output Test Load  
(For tCKLZ, tCKHZ, tOLZ, and tOHZ).  
\*Including scope and jig.

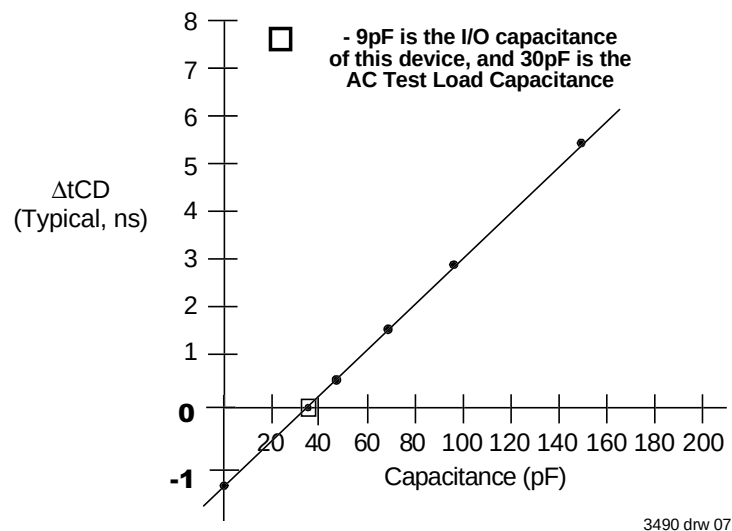


Figure 3. Typical Output Derating (Lumped Capacitive Load).

# AC Electrical Characteristics Over the Operating Temperature Range (Read and Write Cycle Timing)<sup>(3)</sup>

(Commercial:  $V_{CC} = 5V \pm 10\%$ ,  $T_A = 0^\circ C$  to  $+70^\circ C$ ; Military:  $V_{CC} = 5V \pm 10\%$ ,  $T_A = -55^\circ C$  to  $+125^\circ C$ )

| Symbol                    | Parameter                                        | 70914S12<br>Com'l Only |      | 70914S15<br>Com'l Only |      | Unit |
|---------------------------|--------------------------------------------------|------------------------|------|------------------------|------|------|
|                           |                                                  | Min.                   | Max. | Min.                   | Max. |      |
| t <sub>CYC</sub>          | Clock Cycle Time                                 | 16                     | —    | 20                     | —    | ns   |
| t <sub>CH</sub>           | Clock High Time                                  | 6                      | —    | 6                      | —    | ns   |
| t <sub>CL</sub>           | Clock Low Time                                   | 6                      | —    | 6                      | —    | ns   |
| t <sub>CD</sub>           | Clock High to Output Valid                       | —                      | 12   | —                      | 15   | ns   |
| t <sub>S</sub>            | Registered Signal Set-up Time                    | 4                      | —    | 4                      | —    | ns   |
| t <sub>H</sub>            | Registered Signal Hold Time                      | 1                      | —    | 1                      | —    | ns   |
| t <sub>DC</sub>           | Data Output Hold After Clock High                | 3                      | —    | 3                      | —    | ns   |
| t <sub>CKLZ</sub>         | Clock High to Output Low-Z <sup>(1,2)</sup>      | 2                      | —    | 2                      | —    | ns   |
| t <sub>CKHZ</sub>         | Clock High to Output High-Z <sup>(1,2)</sup>     | —                      | 7    | —                      | 7    | ns   |
| t <sub>OE</sub>           | Output Enable to Output Valid                    | —                      | 7    | —                      | 8    | ns   |
| t <sub>OLZ</sub>          | Output Enable to Output Low-Z <sup>(1,2)</sup>   | 0                      | —    | 0                      | —    | ns   |
| t <sub>OHZ</sub>          | Output Disable to Output High-Z <sup>(1,2)</sup> | —                      | 7    | —                      | 7    | ns   |
| t <sub>SCK</sub>          | Clock Enable, Disable Set-up Time                | 4                      | —    | 4                      | —    | ns   |
| t <sub>HCK</sub>          | Clock Enable, Disable Hold Time                  | 2                      | —    | 2                      | —    | ns   |
| <b>Port-to-Port Delay</b> |                                                  |                        |      |                        |      |      |
| t <sub>CWDD</sub>         | Write Port Clock High to Read Data Delay         | —                      | 25   | —                      | 30   | ns   |
| t <sub>CSS</sub>          | Clock-to-Clock Setup Time                        | —                      | 13   | —                      | 15   | ns   |

3490 tbl 08a

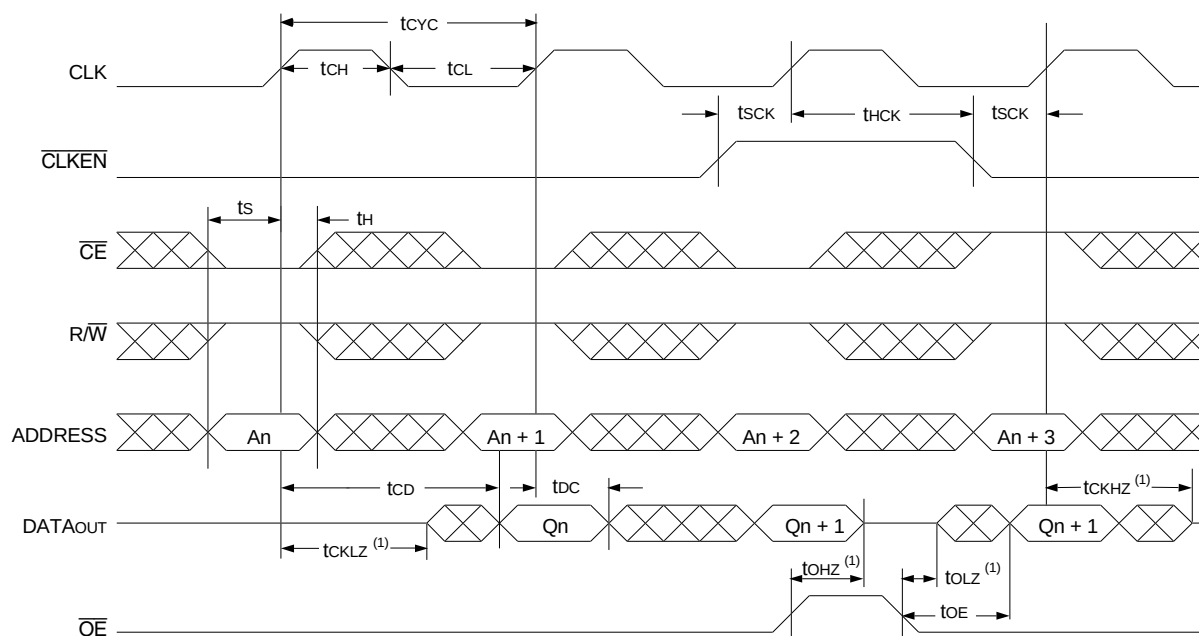
| Symbol                    | Parameter                                        | 70914S20<br>Com'l & Military |      | 70914S25<br>Military Only |      | Unit |
|---------------------------|--------------------------------------------------|------------------------------|------|---------------------------|------|------|
|                           |                                                  | Min.                         | Max. | Min.                      | Max. |      |
| t <sub>CYC</sub>          | Clock Cycle Time                                 | 20                           | —    | 25                        | —    | ns   |
| t <sub>CH</sub>           | Clock High Time                                  | 8                            | —    | 10                        | —    | ns   |
| t <sub>CL</sub>           | Clock Low Time                                   | 8                            | —    | 10                        | —    | ns   |
| t <sub>CD</sub>           | Clock High to Output Valid                       | —                            | 20   | —                         | 25   | ns   |
| t <sub>S</sub>            | Registered Signal Set-up Time                    | 5                            | —    | 6                         | —    | ns   |
| t <sub>H</sub>            | Registered Signal Hold Time                      | 1                            | —    | 1                         | —    | ns   |
| t <sub>DC</sub>           | Data Output Hold After Clock High                | 3                            | —    | 3                         | —    | ns   |
| t <sub>CKLZ</sub>         | Clock High to Output Low-Z <sup>(1,2)</sup>      | 2                            | —    | 2                         | —    | ns   |
| t <sub>CKHZ</sub>         | Clock High to Output High-Z <sup>(1,2)</sup>     | —                            | 9    | —                         | 12   | ns   |
| t <sub>OE</sub>           | Output Enable to Output Valid                    | —                            | 10   | —                         | 12   | ns   |
| t <sub>OLZ</sub>          | Output Enable to Output Low-Z <sup>(1,2)</sup>   | 0                            | —    | 0                         | —    | ns   |
| t <sub>OHZ</sub>          | Output Disable to Output High-Z <sup>(1,2)</sup> | —                            | 9    | —                         | 11   | ns   |
| t <sub>SCK</sub>          | Clock Enable, Disable Set-up Time                | 5                            | —    | 6                         | —    | ns   |
| t <sub>HCK</sub>          | Clock Enable, Disable Hold Time                  | 2                            | —    | 2                         | —    | ns   |
| <b>Port-to-Port Delay</b> |                                                  |                              |      |                           |      |      |
| t <sub>CWDD</sub>         | Write Port Clock High to Read Data Delay         | —                            | 35   | —                         | 45   | ns   |
| t <sub>CSS</sub>          | Clock-to-Clock Setup Time                        | —                            | 15   | —                         | 20   | ns   |

3490 tbl 08b

## NOTES:

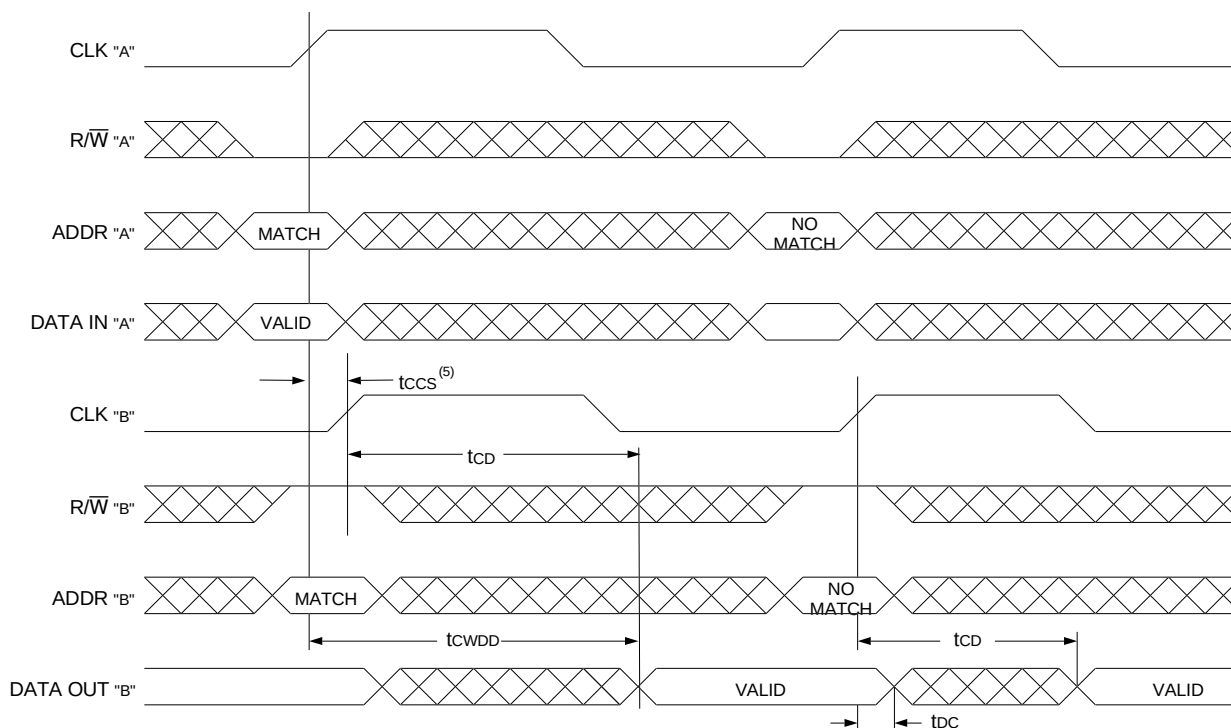
1. Transition is measured 0mV from Low or High impedance voltage with the Output Test Load (Figure 2).
2. This parameter is guaranteed by device characterization, but is not production tested.
3. Industrial temperature: for specific speeds, packages and powers contact your sales office.

## Timing Waveform of Read Cycle, Either Side



3490 drw 08

## Timing Waveform of Write with Port-to-Port Read<sup>(2,3,4)</sup>



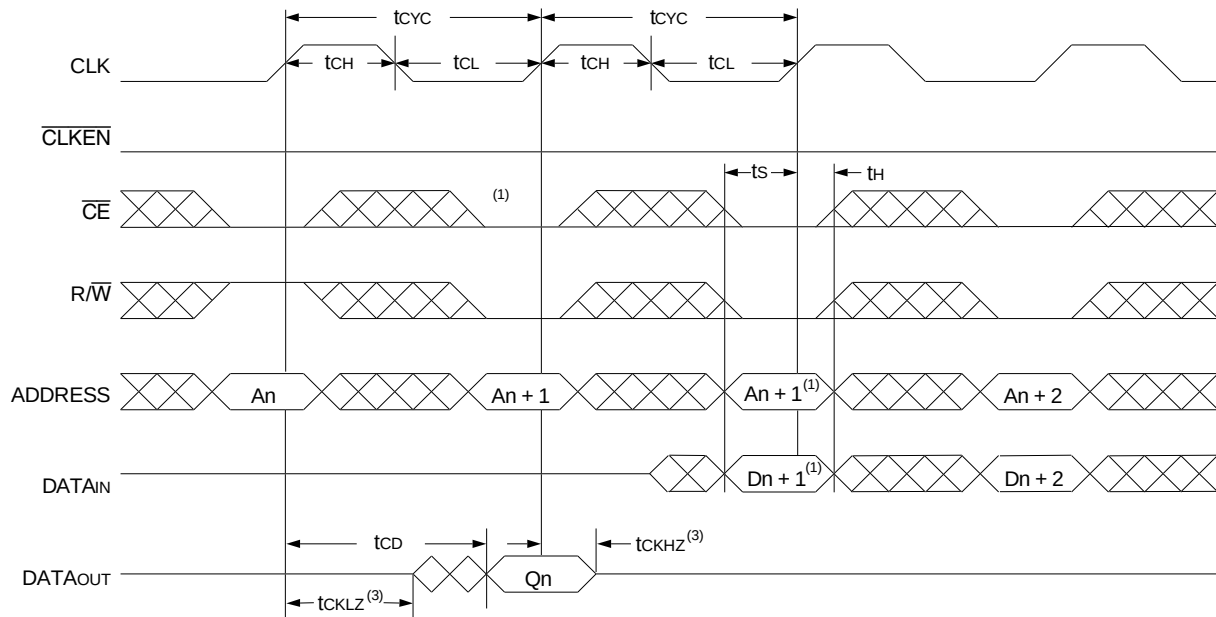
3490 drw 09

### NOTES:

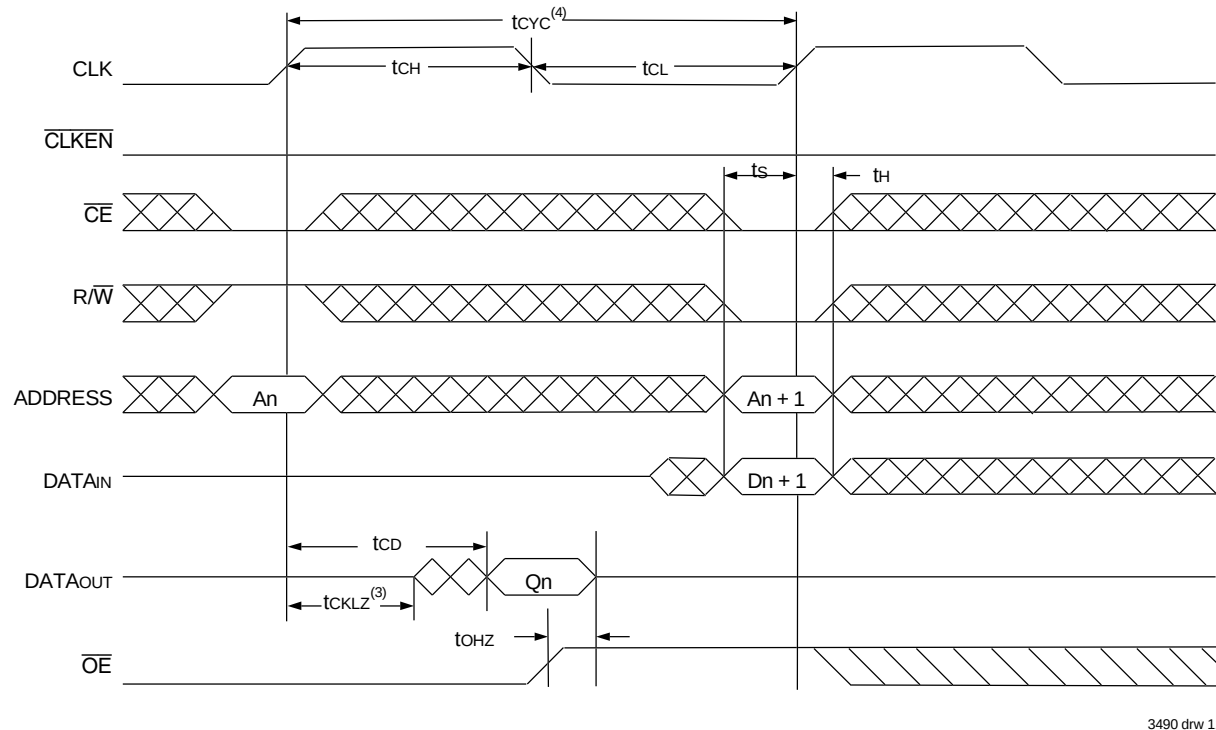
1. Transition is measured  $\pm 200\text{mV}$  from Low or High-impedance voltage with the Output Test Load (Figure 2).
2.  $\overline{\text{CEL}} = \overline{\text{CER}} = V_{\text{IL}}$ ,  $\overline{\text{CLKENL}} = \overline{\text{CLKENR}} = V_{\text{IL}}$ .
3.  $\overline{\text{OE}} = V_{\text{IL}}$  for the reading port, port 'B'.
4. All timing is the same for left and right ports. Ports 'A' may be either the left or right port. Port 'B' is opposite from port 'A'.
5. If  $t_{\text{CCS}} \leq$  maximum specified, then data from right port READ is not valid until the maximum specified for  $t_{\text{CDD}}$ .  
If  $t_{\text{CCS}} >$  maximum specified, then data from right port READ is not valid until  $t_{\text{CCS}} + t_{\text{CD}}$ .  $t_{\text{CDD}}$  does not apply in this case.



## Timing Waveform of Read-to-Write Cycle No. 1<sup>(1,2)</sup> ( $t_{CYC} = \text{min.}$ )



## Timing Waveform of Read-to-Write Cycle No. 2<sup>(4)</sup> ( $t_{CYC} > \text{min.}$ )



### NOTES:

1. For  $t_{CYC} = \text{min.}$ ; data out coincident with the rising edge of the subsequent write clock can occur. To ensure writing to the correct address location, the write must be repeated on the second write clock rising edge. If  $\overline{CE} = V_{IL}$ , invalid data will be written into array. The  $An+1$  must be rewritten on the following cycle.
2.  $\overline{OE}$  LOW throughout.
3. Transition is measured 0mV from Low or High-impedance voltage with the Output Test Load (Figure 2).
4. For  $t_{CYC} > \text{min.}$ ;  $\overline{OE}$  may be used to avoid data out coincident with the rising edge of the subsequent write clock. Use of  $\overline{OE}$  will eliminate the need for the write to be repeated.

## Functional Description

The IDT70914 provides a true synchronous Dual-Port Static RAM interface. Registered inputs provide very short set-up and hold times on address, data, and all critical control inputs. All internal registers are clocked on the rising edge of the clock signal. An asynchronous output enable is provided to ease asynchronous bus interfacing.

The internal write pulse width is dependent on the LOW to HIGH

transitions of the clock signal allowing the shortest possible realized cycle times. Clock enable inputs are provided to stall the operation of the address and data input registers without introducing clock skew for very fast interleaved memory applications.

A HIGH on the  $\overline{CE}$  input for one clock cycle will power down the internal circuitry to reduce static power consumption.

## Truth Table I: Read/Write Control<sup>(1)</sup>

| Inputs                     |                 |                 |                 | Outputs             | Mode                                      |
|----------------------------|-----------------|-----------------|-----------------|---------------------|-------------------------------------------|
| Synchronous <sup>(3)</sup> |                 |                 | Asynchronous    |                     |                                           |
| CLK                        | $\overline{CE}$ | $R\overline{W}$ | $\overline{OE}$ | I/O0-8              |                                           |
| ↑                          | H               | X               | X               | High-Z              | Deselected, Power-Down                    |
| ↑                          | L               | L               | X               | DATA <sub>IN</sub>  | Selected and Write Enabled                |
| ↑                          | L               | H               | L               | DATA <sub>OUT</sub> | Read Selected and Data Output Enable Read |
| ↑                          | X               | X               | H               | High-Z              | Outputs Disabled                          |

3490 tbl 09

## Truth Table II: Clock Enable Function Table<sup>(1)</sup>

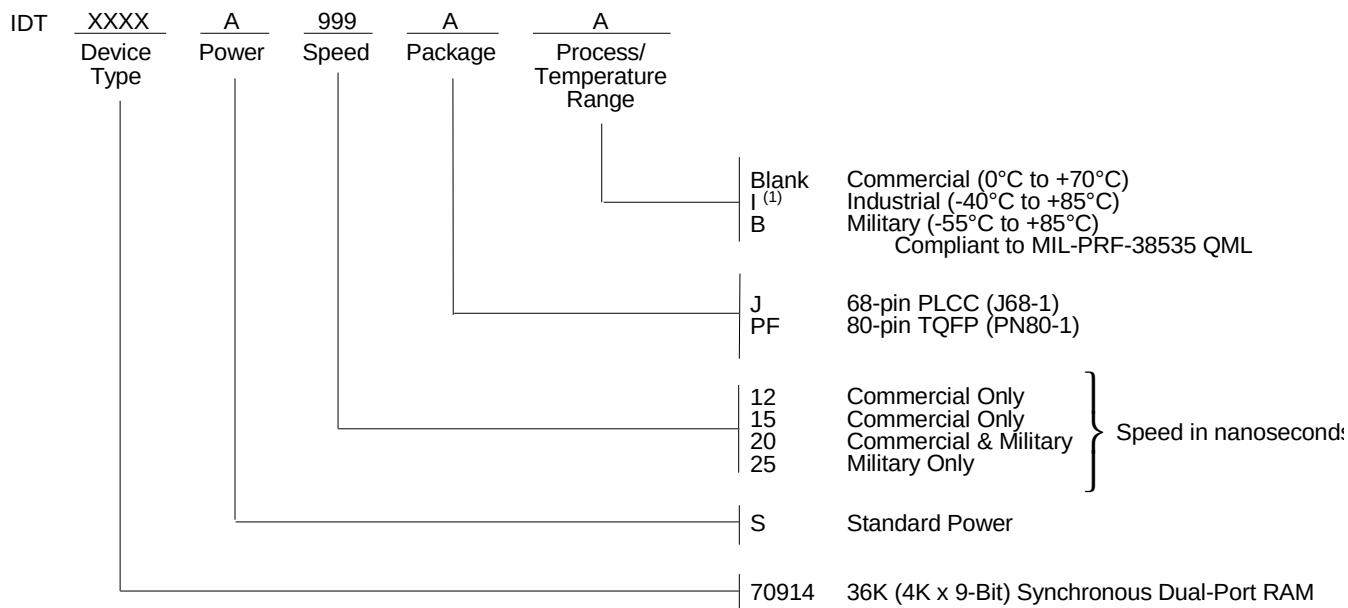
| Mode              | Inputs             |                                   | Register Inputs |                    | Register Outputs <sup>(4)</sup> |                     |
|-------------------|--------------------|-----------------------------------|-----------------|--------------------|---------------------------------|---------------------|
|                   | CLK <sup>(3)</sup> | $\overline{CLKEN}$ <sup>(2)</sup> | ADDR            | DATA <sub>IN</sub> | ADDR                            | DATA <sub>OUT</sub> |
| Load "1"          | ↑                  | L                                 | H               | H                  | H                               | H                   |
| Load "0"          | ↑                  | L                                 | L               | L                  | L                               | L                   |
| Hold (do nothing) | ↑                  | H                                 | X               | X                  | NC                              | NC                  |
|                   | X                  | H                                 | X               | X                  | NC                              | NC                  |

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### NOTES:

- 'H' = HIGH voltage level steady state, 'h' = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition, 'L' = LOW voltage level steady state 'l' = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition, 'X' = Don't care, 'NC' = No change
- $\overline{CLKEN}$  =  $V_{IL}$  must be clocked in during Power-Up.
- Control signals are initiated and terminated on the rising edge of the CLK, depending on their input level. When  $R/\overline{W}$  and  $\overline{CE}$  are LOW, a write cycle is initiated on the LOW-to-HIGH transition of the CLK. Termination of a write cycle is done on the next LOW-to-HIGH transition of the CLK.
- The register outputs are internal signals from the register inputs being clocked in or disabled by  $\overline{CLKEN}$ .

## Ordering Information



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### NOTE:

1. Industrial temperature range is available on selected TQFP packages in standard power.  
 For specific speeds, packages and powers contact your sales office.

## Datasheet Document History

|           |                                                                                                                                                                        |
|-----------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 3/10/99:  | Initiated datasheet document history<br>Converted to new format<br>Cosmetic and typographical corrections<br>Page 2 and 3 Added additional notes to pin configurations |
| 6/7/99:   | Changed drawing format                                                                                                                                                 |
| 11/10/99: | Replaced IDT logo                                                                                                                                                      |
| 5/24/00:  | Page 4 Increased storage temperature parameter<br>Clarified TA parameter<br>Page 5 DC Electrical parameters—changed wording from "open" to "disabled"                  |
| 1/12/01:  | Changed ±200mV to 0mV in notes<br>Removed PGA pinout (obsolete package)<br>Changed cycle time of 12ns part from 17ns (58MHz) to 16ns (60MHz)                           |



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